

Search Notes

Application/Control No.

10/756,381

Examiner

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Applicant(s)/Patent under
Reexamination

NAKAMURA ET AL.

Art Unit

2141

SEARCHED

Class	Subclass	Date	Examiner
709	231	1/2/2008	DB
709	232	1/2/2008	DB
386	70	1/2/2008	DB

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
east	1/2/2008	DB
Double Patenting Search	1/2/2008	db